

October 2014

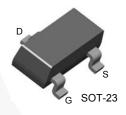
BSS138L N-Channel Logic Level Enhancement Mode Field Effect Transistor

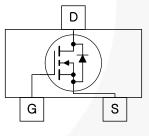
Features

- High Density Cell Design for Low R_{DS(ON)}
- Rugged and Reliable
- Compact Industry Standard SOT-23 Surface Mount Package
- · Very Low Capacitance
- · Fast Switching Speed

Description

This N-channel enhancement mode field effect transistor is produced using high cell density, trench MOSFET technology. This product minimizes on-state resistance while providing rugged, reliable, and fast switching performance. This product is particularly suited for low-voltage, low-current applications such as small servo motor control, power MOSFET gate drivers, logic level translator, high speed line drivers, power management/power supply and switching applications.





Ordering Information

ſ	Part Number	Marking	Package	Packing Method	
	BSS138L	SL	SOT-23 3L	Tape and Reel	

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. Values are at $T_A = 25^{\circ}$ C unless otherwise noted.

Symbol	Parameter	Value	Unit	
V _{DSS}	Drain-Source Voltage		50	V
V _{GSS}	Gate-Source Voltage	±20	V	
	Maximum Drain Current	Continuous	0.20	A
۱ _D		Pulsed	0.80	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temperature for Soldering P for 10 Seconds	300	°C	

Thermal Characteristics

Values are at $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Value	Unit
P_	Maximum Power Dissipation ⁽¹⁾	0.35	W
PD	Derate Above 25°C	2.8	mW/°C
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient ⁽¹⁾	380	°C/W

Note:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a) 380°C/W when mounted on a minimum pad.

Scale 1: 1 on letter size paper

ESD Rating⁽²⁾

Symbol	Parameter	Value	Unit	
HBM	Human Body Model per ANSI/ESDA/JEDEC JS-001-2012	50	50	
CDM	Charged Device Model per JEDEC C101C	>2000		

Note:

2. ESD values are in typical, no over-voltage rating is implied, ESD CDM zap voltage is 2000 V maximum.

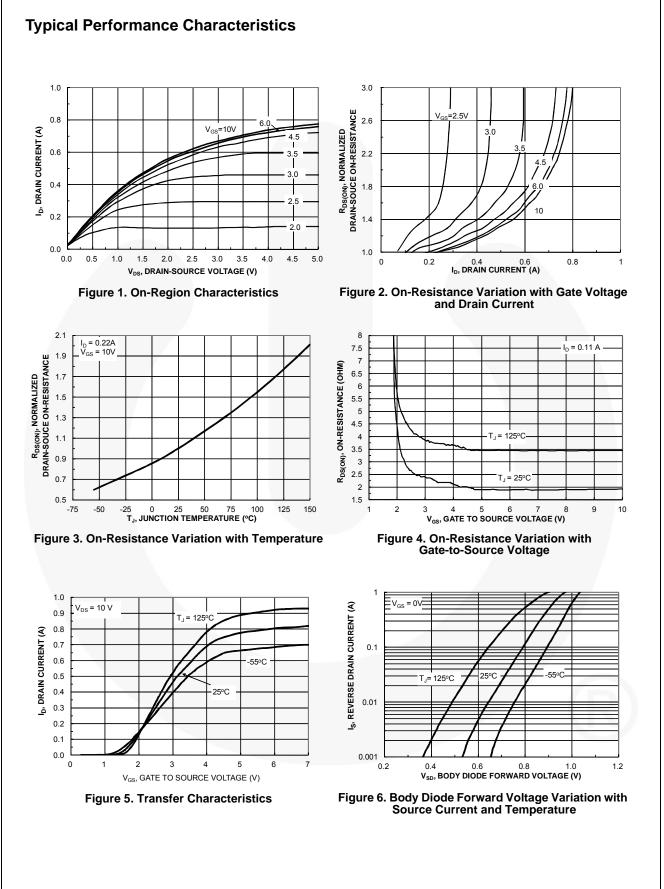
Electrical Characteristics

Values are at $T_A = 25^{\circ}C$ unless otherwise noted.

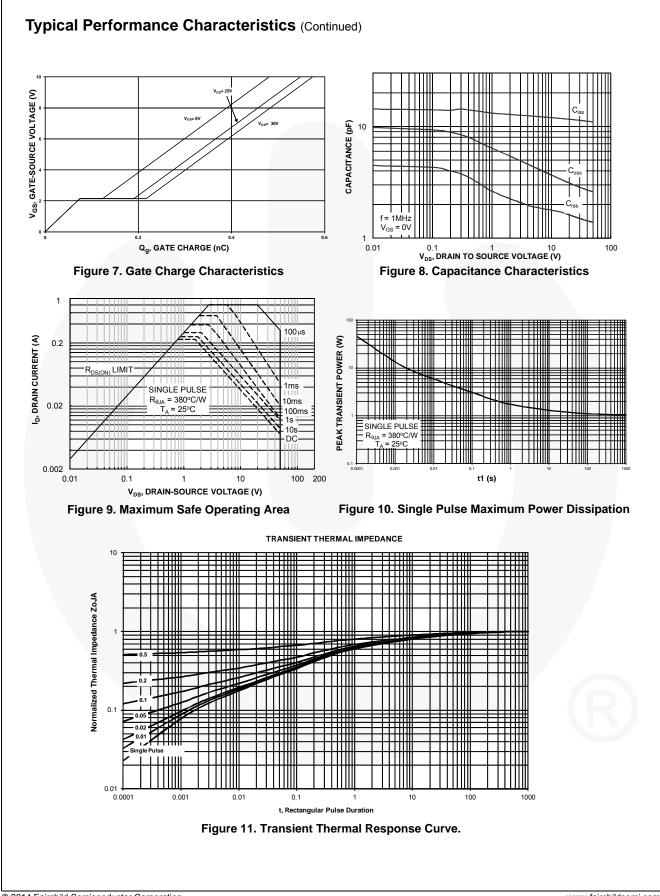
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	50.0	65.4		V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		58		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = 50 V, V _{GS} = 0 V		0.263	500	nA
I _{DSS}		V _{DS} = 50 V, V _{GS} = 0 V, T _J = 125°C		0.109	5	μA
		V _{DS} = 30 V, V _{GS} = 0 V		0.062	100	nA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V		0.058	100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V		-0.06	-100	
On Charac	teristics ⁽³⁾					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$	0.80	1.25	1.50	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 1 mA, Referenced to 25°C		-2.42		mV/°C
Р	Static Drain-Source On-Resistance	V _{GS} = 5 V, I _D = 0.20 A		2.78	3.50	0
R _{DS(ON)}		V _{GS} = 2.75 V, I _D = 0.20 A		3.78	10	Ω
I _{D(ON)}	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	0.20	0.67		Α
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 0.22 A	0.12	0.35		S
Dynamic C	haracteristics					
C _{iss}	Input Capacitance			12.2	50	pF
C _{oss}	Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		3.04	25	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1.0 WHZ		1.43	5	pF
R _G	Gate Resistance	V _{GS} = 15 V, V _{GS} = 1.0 MHz		26.6		Ω
Switching	Characteristics ⁽³⁾					
t _{d(on)}	Turn-On Delay			2.2	5	ns
t _r	Turn-On Rise Time	V _{DD} = 30 V, I _D = 0.29 A,		1.8	18	ns
t _{d(off)}	Turn-Off Delay	V _{GS} = 10 V		5.3	36	ns
t _f	Turn-Off Fall Time			5.1	14	ns
Qg	Total Gate Charge			0.549	2.4	nC
Q _{gs}	Gate-Source Charge	$V_{DS} = 25 \text{ V}, I_D = 0.22 \text{ A},$		0.075		nC
Q _{gd}	Gate-Drain Charge	V _{GS} = 10 V, I _G = 0.1 mA		0.117		nC
0	ce Diode Characteristics and Ma	ximum Ratings				
۱ _S	Maximum Continuous Drain-Source	ce Diode Forward Current			0.22	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 115 mA		0.93	1.4	V

Note:

3. Pulse test: pulse width ≤ 300 μ s, duty cycle ≤ 2.0%.

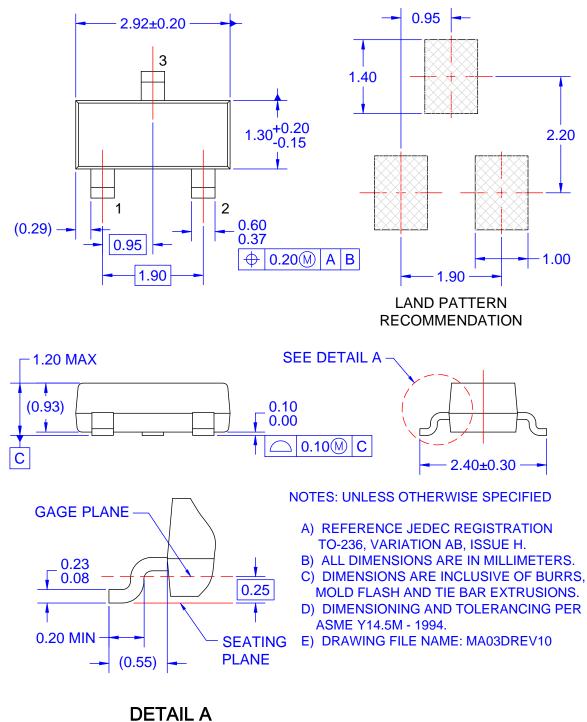


BSS138L — N-Channel Logic Level Enhancement Mode Field Effect Transistor



© 2014 Fairchild Semiconductor Corporation BSS138L Rev. 1.0.1

BSS138L — N-Channel Logic Level Enhancement Mode Field Effect Transistor



SCALE: 2X

E: 2X

FAIRCHILD. TRADEMARKS The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks. **OPTOPLANAR[®]** AccuPower™ F-PFS™ FRFET® Awinda[®] ® AX-CAP®* Global Power ResourceSM TinyBoost[®] BitSiC™ GreenBridge™ TinyBuck® PowerTrench[®] Build it Now™ Green FPS™ TinyCalc™ PowerXS™ Programmable Active Droop™ CorePLUS™ Green FPS™ e-Series™ TinyLogic® TINYOPTO™ CorePOWER™ Gmax™ QFET CROSSVOLT™ TinvPower™ GTO™ QS™ TinyPWM™ CTL™ IntelliMAX™ Quiet Series™ TinyWire™ Current Transfer Logic™ ISOPLANAR™ RapidConfigure™ **DEUXPEED**® Making Small Speakers Sound Louder TranSiC™ Dual Cool™ and Better™ TriFault Detect™ Saving our world, 1mW/W/kW at a time™ **EcoSPARK**[®] TRUECURRENT®* MegaBuck™ SignalWise™ EfficientMax™ MICROCOUPLER™ uSerDes™ SmartMax™ ESBC™ MicroFET™ N SMART START™ R MicroPak™ F Solutions for Your Success™ MicroPak2™ UHC Fairchild® SPM[®] MillerDrive™ Ultra FRFET™ Fairchild Semiconductor® STEAL THT MotionMax™ UniFET™ FACT Quiet Series™ SuperFET[®] MotionGrid® VCX™ FACT[®] FAST[®] SuperSOT™-3 MTi[®] VisualMax™ SuperSOT™-6 MTx® VoltagePlus™ FastvCore™ SuperSOT™-8 MVN® XS™ FFTBench™ SupreMOS[®] Xsens™ mWSaver® FPS™ SyncFET™ OptoHiT™ 仙童™ Sync-Lock™ OPTOLOGIC[®] * Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. TO OBTAIN THE LATEST, MOST UP-TO-DATE DATASHEET AND PRODUCT INFORMATION, VISIT OUR WEBSITE AT <u>HTTP://WWW.FAIRCHILDSEMI.COM</u>. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are
 intended for surgical implant into the body or (b) support or sustain
 life, and (c) whose failure to perform when properly used in
 accordance with instructions for use provided in the labeling, can be
 reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.
		Rev. 172



Authorized Distribution Brand :



Website :

Welcome to visit www.ameya360.com

Contact Us :

➤ Address :

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd Minhang District, Shanghai , China

- > Sales :
 - Direct +86 (21) 6401-6692
 - Email amall@ameya360.com
 - QQ 800077892
 - Skype ameyasales1 ameyasales2

> Customer Service :

Email service@ameya360.com

> Partnership :

Tel +86 (21) 64016692-8333

Email mkt@ameya360.com